

# March 2012 SuperFET® II

### FCP190N60 / FCPF190N60

### 600V N-Channel MOSFET

#### **Features**

- 650V @T<sub>.I</sub> = 150°C
- Max.  $R_{DS(on)} = 199m\Omega$
- Ultra low gate charge (typ. Q<sub>g</sub> = 57nC)
- Low effective output capacitance (typ. C<sub>oss</sub>.eff = 160pF)
- · 100% avalanche tested

### **Description**

SuperFET®II is, Fairchild's proprietary, new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.

This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFET<sup>®</sup>II is very suitable for various AC/DC power conversion in switching mode operation for system miniaturization and higher efficiency.



#### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol		Parameter		FCP190N60	FCPF190N60	Units
V <sub>DSS</sub>	Drain to Source Voltage			6	00	V
\ /	Cata ta Causaa Valtana	-DC		±	20	.,
$V_{GSS}$	Gate to Source Voltage	-AC	(f >1Hz)	±	30	V
	Drain Current	-Continuous (T <sub>C</sub> = 25°C)		20.2	20.2*	^
ID	Drain Current	-Continuous (T <sub>C</sub> = 100°C)		12.7	12.7*	Α
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	60.6	60.6*	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		2) 400		mJ	
I <sub>AR</sub>	Avalanche Current (N		(Note 1)	) 4.0		Α
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	1) 2.1		mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	3) 20		V/ns
uv/ut	MOSFET dv/dt			1	00	V/ns
D	Bower Dissipation	(T <sub>C</sub> = 25°C)		208	39	W
$P_{D}$	Power Dissipation	- Derate above 25°C		1.67	0.31	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to	+150	٥С
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300		οС

<sup>\*</sup>Drain current limited by maximum junction temperature

#### **Thermal Characteristics**

Symbol	Parameter	FCP190N60	FCPF190N60	Units
$R_{ heta JC}$	Thermal Resistance, Junction to Case	0.6	3.2	
$R_{\theta CS}$	Thermal Resistance, Case to Heat Sink (Typical)		0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FCP190N60	FCP190N60	TO-220	-	-	50
FCPF190N60	FCPF190N60	TO-220F	-	-	50

## **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
D\/	Drain to Source Breakdown Voltage	$V_{GS} = 0V, I_D = 10mA, T_J = 25^{\circ}C$	600	-	-	V
BV <sub>DSS</sub>	Diam to Source Breakdown voltage	$V_{GS} = 0V, I_D = 10mA, T_J = 150$ °C	650	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 10mA, Referenced to 25°C	-	0.67	-	V/°C
BV <sub>DS</sub>	Drain-Source Avalanche Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 20A	-	700	-	V
1	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 480V, V <sub>GS</sub> = 0V	-	-	1	^
DSS Zero Gate Voltage Drain Current		$V_{DS} = 480V, T_{C} = 125^{\circ}C$	-	-	10	μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

#### On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	-	3.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 10A$	-	0.17	0.199	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 20V, I_{D} = 10A$	-	21	-	S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	\\ - 25\\ \\ - 0\\	-	2220	2950	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V f = 1MHz	-	1630	2165	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 11/11/2	-	85	128	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ = 380V, $V_{GS}$ = 0V, f = 1.0MHz	-	42	1	pF
Coss eff.	Effective Output Capacitance	$V_{DS}$ = 0V to 480V, $V_{GS}$ = 0V	-	160	1	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V	V <sub>DS</sub> = 380V, I <sub>D</sub> = 10A	-	57	74	nC
$Q_{gs}$	Gate to Source Gate Charge	V <sub>GS</sub> = 10V	-	9	1	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	(Note 4)	-	21	-	nC
ESR	Equivalent Series Resistance	Drain open		1		Ω

#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time			-	20	50	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 380V, I_{D} = 10A$		-	10	30	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10V, $R_g$ = 4.7 $\Omega$		-	64	138	ns
t <sub>f</sub>	Turn-Off Fall Time		(Note 4)	-	5	20	ns

#### **Drain-Source Diode Characteristics**

IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	20.2	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Fo	Maximum Pulsed Drain to Source Diode Forward Current		-	60.6	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 10A	-	-	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 10A	-	280	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	3.8	-	μС

#### Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2.  $I_{AS}$  = 4A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25 $^{\circ}$ C
- 3.  $I_{SD} \le 10 \text{A}$ , di/dt  $\le 200 \text{A}/\mu\text{s}$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J$  = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

### **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

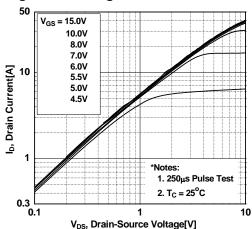


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

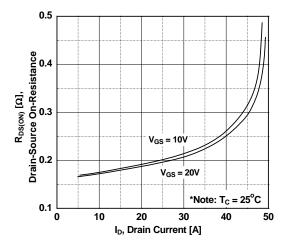


Figure 5. Capacitance Characteristics

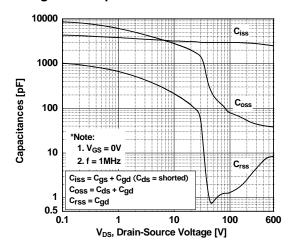


Figure 2. Transfer Characteristics

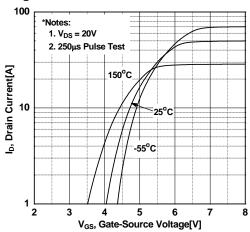


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

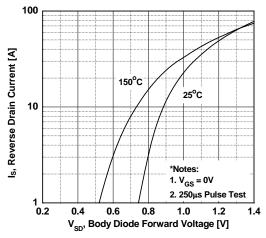
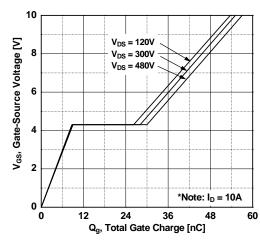


Figure 6. Gate Charge Characteristics



### **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

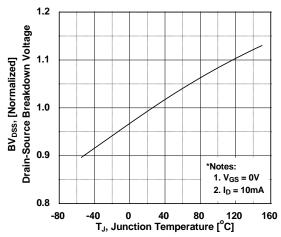
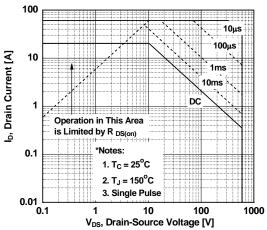


Figure 9. Maximum Safe Operating Area vs. Case Temperature - FCP190N60



**Figure 11. Maximum Drain Current** 

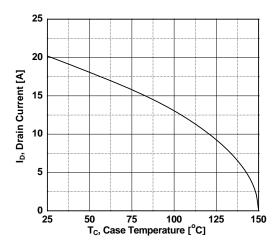


Figure 8. On-Resistance Variation vs. Temperature

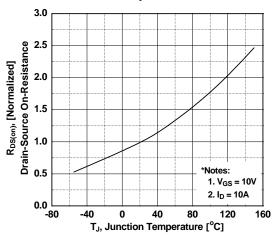


Figure 10. Maximum Safe Operating Area vs. Case Temperature - FCPF190N60

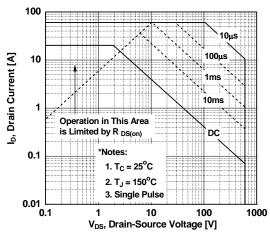
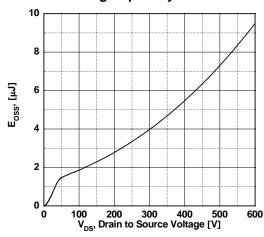


Figure 12. Eoss vs. Drain to Source Voltage Switching Capability



### **Typical Performance Characteristics** (Continued)

Figure 13. Transient Thermal Response Curve - FCP190N60

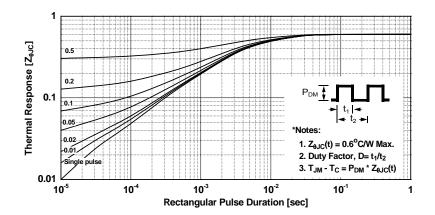
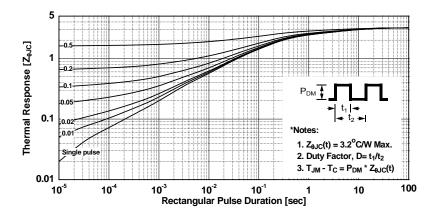
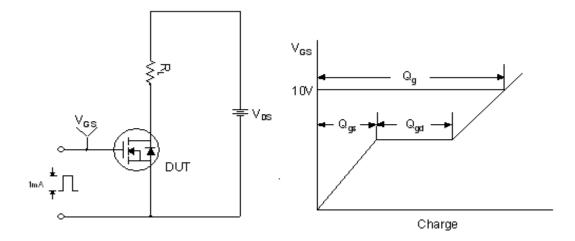


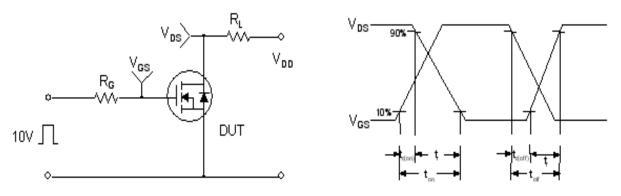
Figure 14. Transient Thermal Response Curve - FCPF190N60



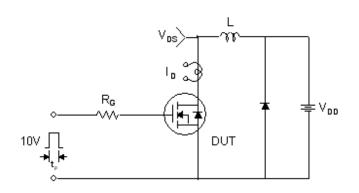
#### **Gate Charge Test Circuit & Waveform**

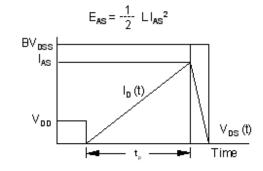


#### **Resistive Switching Test Circuit & Waveforms**

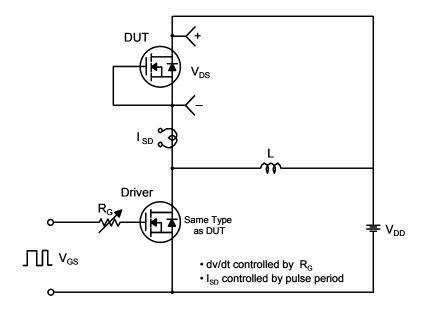


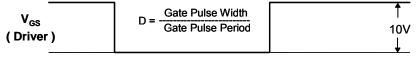
#### **Unclamped Inductive Switching Test Circuit & Waveforms**

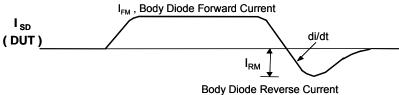




#### Peak Diode Recovery dv/dt Test Circuit & Waveforms







Body Diode Recovery dv/dt

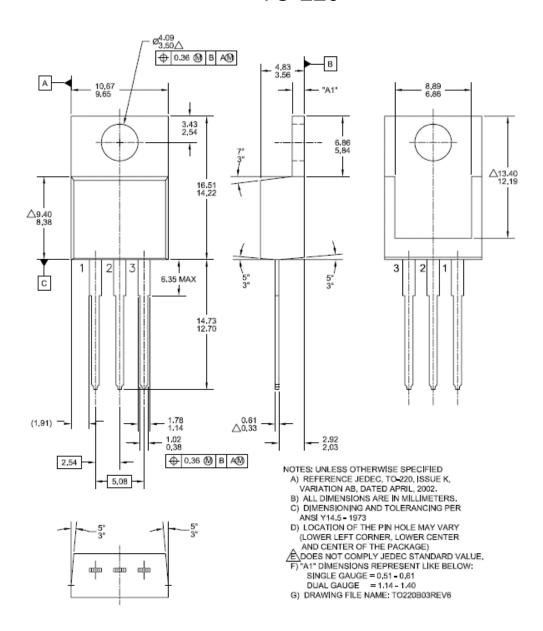
V<sub>SD</sub>

Body Diode

Forward Voltage Drop

#### **Mechanical Dimensions**

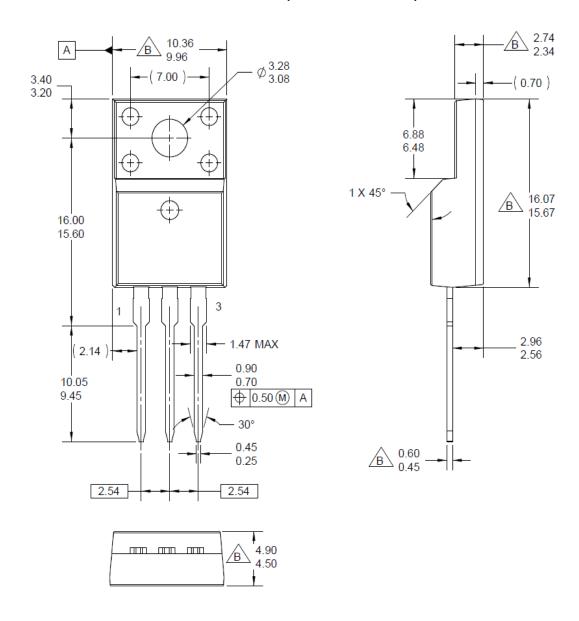
## **TO-220**



Dimensions in Millimeters

### **Package Dimensions**

## TO-220F (Retractable)



\* Front/Back Side Isolation Voltage : AC 2500V

**Dimensions in Millimeters** 





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